## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Seria! No.:

Filed:

December 22, 1999

Title: USE OF A PLASMA SOURCE TO FORM A LAYER DURING THE FORMATION OF A SEMICONDUCTOR DEVICE Group Art Unit:

2825

Application Examiner: Calvin Lee

Atty. Docket:

94-0280.03

AMENDMENT AND RESPONSE TO THE OFFICE ACTION DATED JULY 31, 2001

Commissioner for Patents Washington, D.C. 20231

Dear Sir:

Certificate of Mailing I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to:

Applicants submit this Amendment and Response to the Office Action dated July 31, 2001. Please amend the above-captioned application as follows.

## IN THE CLAIMS

- Please cancel claim 44 without prejudice.
- Please amend claim 45 to the following form.

45. (Twice amended) A method of providing a polymer between metal features on a wafer, comprising:

performing a deposition on said wafer in a site; and etching in the same general site used to perform said deposition, wherein said step of etching further comprises etching generally simultaneously with performing said deposition.